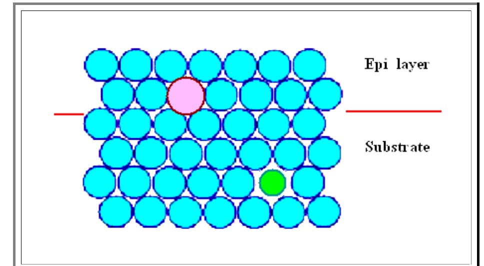
6.2 Chemical Vapor Deposition

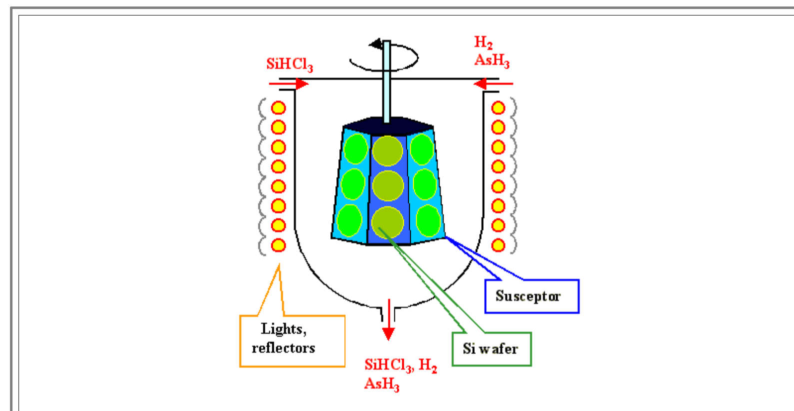
6.2.1 Silicon Epitaxy

- We have encountered the need for epitaxial layers before, and we also have seen a **Si CVD** process for making poly-crystalline material good enough for growing crystals. All we have to do now is to put both things together.
  - We can use essentially the same **CVD** process as before, but instead of thin rods of poly-**Si** which we want to grow in diameter as fast as possible, we now want to make a thin, but absolutely perfect **Si** layer on top of a wafer.

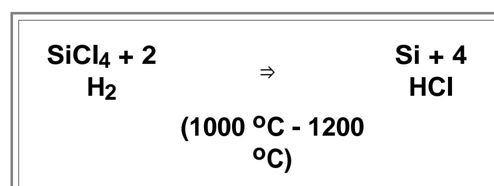
- We now must have tremendous process control. We require:
  - A *precise continuation* of the substrate lattice. There should be no way whatsoever to identify the interface after the epitaxial layer has been deposited. This means that *no lattice defects whatsoever* should be generated.
  - *Doping* of the epitaxial layer with high precision (e.g. **5 Ωcm ± 5%**), and the doping is usually very different from that of the substrate. The picture on the right symbolizes that by the two differently colored doping atoms.
  - *Precise thickness control*, e.g. ***d* = 1.2 µm ± 10%** over the entire wafer, from wafer to wafer and from day to day. Now there is a challenge: If you met the first point and thus can't tell where the interface is - how do you measure the thickness? (The answer: Only electronically, e.g. by finding the position of the **pn**-junction produced).
  - *Cleanliness*: No contaminants diffusing into the substrate and the epitaxial layer are allowed.



- This looks tough and it is indeed fairly difficult to make good epitaxial layers. It is also quite expensive and is therefore avoided whenever possible (e.g. in mainstream **CMOS** technology). It is, however, a must in bipolar and some other technologies and also a good example for a very demanding process with technical solutions that are far from obvious.
- Lets look at a typical epitaxial reactor from around **1990** (newer ones tend to be single wafer systems). It can process several wafers simultaneously and meets the above conditions. Here is a muchly simplified drawing:



- The chemical reaction that produces the **Si** is fairly simple:



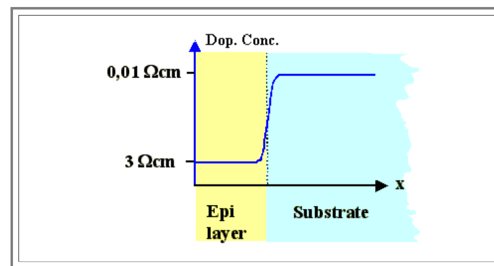
  - The dopant gases just decompose or react in similar ways. However, instead of **$SiCl_4$** you may want to use **SiH_xCl_{4-x}** .
  - The essential point is that the process needs high temperatures and the **Si** wafer will be at high temperature! In an Epi reactor as shown above, the **Si** wafer surfaces (and whatever shows of the susceptor) are the only hot surfaces of the system!
- How is the process actually run? You need to meet some tight criteria for the layer specifications, as outlined above, and that transfers to tight criteria for process control.

- **1.** *Perfectly clean* **Si** surface before you start. This is not possible by just putting clean **Si** wafers inside the Epi-reactor (they always would be covered with SiO_2), but requires an in-situ cleaning step. This is done by first admitting only H_2 and Cl_2 into the chamber, at a very high temperature of about **1150 °C**. **Si** is etched by the gas mixture - every trace of SiO_2 and especially foreign atoms at the surface will be removed.
- **2**. Temperature gradients of at most **(1 - 2) °C**. This is (better: was) achieved by **heating with light** as shown in the drawing. The high intensity light bulbs (actually rods) consume about **150 kW** electrical power (which necessitates a **30 kW** motor running the fan for air-cooling the machinery).
- **3.** Extremely tightly controlled gas flows within a range of about **200 l/min** H_2, **5 l/min** $SiCl_4$ (or **Si** HCl_3), and fractions of **ml/min** of the doping gases.

Not to forget: Epi-reactors are potentially very dangerous machines with a lot of "dirty" output that needs to be cleaned. All things taken together make Epi-reactors very expensive - you should be prepared to spend several million **$** if you want to enter this technology.

- **Si** epitaxy thus is a process that is avoided if possible - it costs roughly **$5** per wafer, which is quite a lot. So when do we use epitaxy?

Epitaxy is definitely needed if a *doping profile* is required where the *resistivity in surface near regions is larger than in the bulk*. In other words, a profile like this:



- By diffusion, you can always lower the resistivity and even change the doping type, but *increasing the resistivity by diffusion* is not realistically possible.
- Consider a substrate doping of 10^{16} cm^3. Whatever resistivity it has (around **5 - 10 Ωcm**), if you diffuse $2 \cdot 10^{16}$ cm^3 of a dopant into the substrate, you *lowered* the resistivity of the doped layer by a factor of **2.**
- To *increase* the resistivity you have to compensate half of the substrate doping by diffusing a dopant for the reverse doping type with a concentration of $5 \cdot 10^{15}$ cm^3. Not only does that call for much better precision in controlling diffusion, but you will only get that value at a particular distance from the surface because you always have a diffusion profile. So all you can do by diffusion is to increase the resistivity somewhat near the surface regions; but you cannot make a sizeable layer this way.

You also may use epitaxial layers if you simply need a *degree of freedom in doping* that is not achievable otherwise.

- While **DRAMs** were made without epitaxy up to the **16 Mbit** generation (often to the amazement of everybody, because in the beginning of the development work epitaxy seemed to be definitely necessary), epitaxial **Si** layers are now included from the **64 Mbit DRAM** upwards.